

## PIN Photodiode

### Key Features

InGaAs Material

Planar Zn Diffused Structure

Top-illuminated Photodiode

Wide Active Area (300 micron or 500 micron in Diameter)

Low Dark Current

High Responsivity

Avanex Reliability and Qualification Program for Built in Quality

Flip-Chip mounting

### Applications

2.5Gb/s Receiver Modules

Telecom

Instrumentation

### For more info

Please contact us at:

North America: **514.748.4848**  
**888.922.1044**

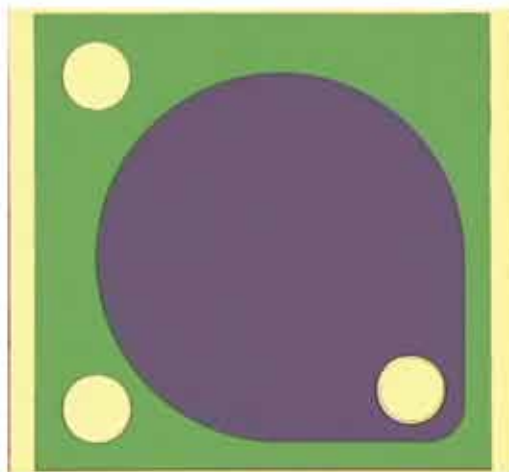
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or via e-mail at [sales@3spgroup.com](mailto:sales@3spgroup.com)

## 1932 DCv1AG

### Flip-Chip InGaAs Monitoring PIN Photodiode

1932 DC chip is a flip-chip monitoring photodiode for DC and low frequency monitoring of optical signal. It is based on InGaAs material grown by Metal Organic Vapor Deposition (MOCVD) on InP substrates. The InGaAs PIN photodiode, which diameter is 300 or 500 microns, is realized with Zinc diffusion and with a planar structure for high reliability.

1932 DC chip is a top-illuminated monitoring photodiode compatible with flip-chip mounting suitable for a wide operating wavelength range and available on different sub-mounts.



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### ELECTRO-OPTICAL CHARACTERISTICS

The following parameters are specified Beginning of Life for chips mounted p-up on Alumina submount and Tsubmount= 25°C.

Parameters	Test conditions	Sym.	Min	Typ	Max.	Unit
Dark current	-5V, 25°C	I <sub>dark</sub>	-	-	10	nA
Dark current	-5V, 75°C	I <sub>dark</sub>	-	-	100	nA
Breakdown voltage (reverse bias)	1μA	V <sub>br</sub>	20	-	-	V
Responsivity	λ = 1.3μm -3V, 100μm	S	0.8	-	-	A/W
Responsivity	λ = 1.55μm -3V, 100μm	S	0.85	-	-	A/W
Capacitance	1 MHz; -3V	C	-	-	15	pF
Forward voltage	@10mA	V <sub>f</sub>	-	-	2	V

### Absolute Maximum Ratings

Exposing the device to stresses above those listed in this section could cause permanent damage. The device is not meant to operate under conditions outside the operational limits described in subsequent sections.

Exposure to absolute maximum rating conditions for extended periods may adversely affect device reliability.

Parameter Conditions	Symbol	Min	Max	Unit
Storage temperature	T <sub>stg</sub>	-40	85	°C
Operating temperature	T <sub>op</sub>	-40	85	°C
Photodiode reverse voltage	V <sub>r</sub>	-	15	V
Photodiode forward current	I <sub>f</sub>	-	10	mA
Optical power	P <sub>in</sub>	-	10	mW
ESD*	VESD	400	-	V

\* Human Body model

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PIN Photodiode

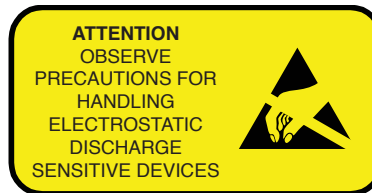


## Handling

This product is sensitive to electrostatic discharge and should not be handled except at a static free workstation.

Take precautions to prevent ESD; use wrist straps, grounded work surfaces and recognized antistatic techniques when handling the product.

Care should be taken to avoid supply transient and over voltage. Over voltage above the maximum specified in absolute maximum rating section may cause permanent damage to the device.



## Ordering Information

Part Number 3CN01281XX

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Please note: information in this document is typical and must be specifically confirmed in writing by your supplier before it becomes applicable to any order or contract. Information is subject to change without notice.  
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## ORDERING INFO

Please contact your Sales Manager. 3SPGroup can also develop custom products to meet a wide range of technical requirements.

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